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Fairchild Semiconductor MCT4R

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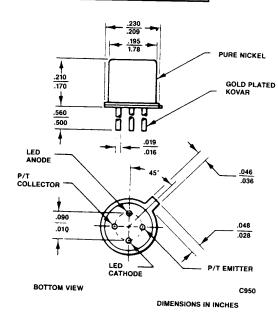




# RELIABILITY CONDITIONED HERMETIC PHOTOTRANSISTOR OPTOCOUPLER

### MCT4R

### PACKAGE DIMENSIONS



#### DESCRIPTION

The MCT4R is a standard four-lead, TO-18 package containing a GaAs infrared emitting diode optically coupled to a silicon planar phototransistor.

### **FEATURES**

- Hermetic package
- High current transfer ratio; typically 35%
- High isolation resistance, 10<sup>11</sup> ohms at 500 volts
- High voltage isolation emitter to detector
- Screened to MIL-STD-883 Class B

#### APPLICATIONS

The MCT4R is designed and manufactured to conform to the requirements of military systems. Reliability testing has proven the product capable of conforming to the screening and quality conformance requirements of MIL-STD-883C Class B devices.

SCREEN—100%		
Characteristic	Method	
nternal Visual Stabilization Bake Femperature Cycle Centrifuge Hermeticity Critical Electrical Surn In Final Electrical Group A Sample Inspection External Visual	2010 — Characteristics applicable to device 1008 — 150°C. for 48 hours 1010 — 10 cycles; -55°C., 25°C., 150°., 25°C. 2001 — Test Condition E 1014 — Fine and Gross — Data Sheet 1015 — 160 hours @ 125°C — Data Sheet 5005 Table I Subgroups 2009	

## **Distributor of Fairchild Semiconductor: Excellent Integrated System Limited**Datasheet of MCT4R - OPTOISO 1KV TRANSISTOR TO206AA

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CHARACTERISTIC	METHOD	LTPD
Subgroup I Visual Mechanical Marking Permanency Physical Dimensions	2008	15%
Subgroup II Solderability	2003	15%
Subgroup III Thermal Shock Temperature Cycle Moisture Resistance Critical Electrical	1011 — 15 cycles; 150°C. to -65°C. 1010 — 10 cycles; -55°C., 25°C., 150°C., 25°C. 1004 — Data Sheet	15%
Subgroup IV Mechanical Shock Vibration Fatigue Vibration Variable Frequency Constant Acceleration Critical Electrical	2002 — Condition B 2005 — Condition A 2007 — Condition A 2001 — Condition E — Data Sheets	15%
Subgroup V Lead Fatigue Hermeticity	2004 — Condition B <sub>2</sub> 1014 — Fine Condition A Gross Condition C	15%
Subgroup VI Salt Atmosphere	1009 — Condition A	15%

CHARACTERISTIC	METHOD	LTPD
Subgroup VII High Temperature Storage Critical Electrical	1008 — 150°C. for 1000 hours — Data Sheet	7%
Subgroup VIII Operating Life Critical Electrical	1005 — Condition B — Data Sheets	7%
Subgroup IX Steady State Reverse Bias	1015 — Condition A; 72 hours at 150°C.	7%

Reference: MIL-STD-883C Test Methods and Procedures for Microelectronics.



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- A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

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